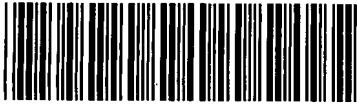


Search Notes

Application/Control No.

10/506,509

Examiner

Sikyin Ip

Applicant(s)/Patent under
Reexamination

OISHI ET AL.

Art Unit

1742

SEARCHED

Class	Subclass	Date	Examiner
148	420		
420	407-409	9/29/2007	SI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/29/2007	SI